

FCC Test Report

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Test Model: M-R0067

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Applicant: LOGITECH FAR EAST LTD.

Address: #2 Creation Rd. 4, Science-Based Ind. Park Hsinchu Taiwan, R.O.C.

- **Issued By:** Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch Hsin Chu Laboratory
- Lab Address: E-2, No.1, Li Hsin 1st Road, Hsinchu Science Park, Hsinchu City 300, Taiwan R.O.C.
- **Test Location (1):** E-2, No.1, Li Hsin 1st Road, Hsinchu Science Park, Hsinchu City 300, Taiwan R.O.C.
- Test Location (2): No. 49, Ln. 206, Wende Rd., Shangshan Tsuen, Chiung Lin Hsiang, Hsin Chu Hsien 307, Taiwan R.O.C.



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	Release Control Record	
Issue No.	Description	Date Issued
RF161220E09-1	Original release.	Dec. 30, 2016



1 Certificate of Conformity

Product:	Cordless Mouse
Brand:	Logitech
Test Model:	M-R0067
Sample Status:	ENGINEERING SAMPLE
Applicant:	LOGITECH FAR EAST LTD.
Test Date:	Dec. 22 to 28, 2016
Standards:	47 CFR FCC Part 15, Subpart C (Section 15.247)
	ANSI C63.10: 2013

The above equipment has been tested by **Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch**, and found compliance with the requirement of the above standards. The test record, data evaluation & Equipment Under Test (EUT) configurations represented herein are true and accurate accounts of the measurements of the sample's EMC characteristics under the conditions specified in this report.

Prepared by :	C- L	,	Date:	Dec. 30, 2016
	Claire Kuan / Specialist	· ·		
Approved by :	May Chen / Manager	_,	Date:	Dec. 30, 2016



2 Summary of Test Results

	47 CFR FCC Part 15, Sub	part C (SEC	TION 15.247)
FCC Clause	Test Item	Result	Remarks
15.207	AC Power Conducted Emission	PASS	Meet the requirement of limit. Minimum passing margin is -11.56dB at 0.41172MHz.
15.205 / 15.209 / 15.247(d)	Radiated Emissions and Band Edge Measurement	PASS	Meet the requirement of limit. Minimum passing margin is -7.1dB at 2483.50MHz.
15.247(d)	Antenna Port Emission	PASS	Meet the requirement of limit.
15.247(a)(2)	6dB bandwidth	PASS	Meet the requirement of limit.
15.247(b)	Conducted power	PASS	Meet the requirement of limit.
15.247(e)	Power Spectral Density	PASS	Meet the requirement of limit.
15.203	Antenna Requirement	PASS	No antenna connector is used.

2.1 Measurement Uncertainty

Where relevant, the following measurement uncertainty levels have been estimated for tests performed on the EUT as specified in CISPR 16-4-2:

Measurement	Frequency	Expanded Uncertainty (k=2) (±)
Conducted Emissions at mains ports	150kHz ~ 30MHz	1.83 dB
Radiated Emissions up to 1 GHz	30MHz ~ 1GHz	5.34 dB
	1GHz ~ 6GHz	3.41 dB
Radiated Emissions above 1 GHz	6GHz ~ 18GHz	3.49 dB
	18GHz ~ 40GHz	3.30 dB

2.2 Modification Record

There were no modifications required for compliance.



3 General Information

3.1 General Description of EUT

Product	Cordless Mouse
Brand	Logitech
Test Model	M-R0067
Status of EUT	ENGINEERING SAMPLE
Power Supply Rating	DC 3.7V from battery or DC 5V from USB interface
Modulation Type	GFSK
Transfer Rate	2Mbps
Operating Frequency	2405MHz ~ 2474MHz
Number of Channel	12
Output Power	2.5mW
Antenna Type	Chip antenna (Antenna gain: 0.16 dBi)
Antenna Connector	NA
Accessory Device	NA
Data Cable Supplied	USB cable x 1 (shielded, 0.7m)

Note:

1. The EUT may have a lot of colors for marketing requirement.

2. The EUT could be supplied with a battery as the following table:

No.	Brand	· · · · · · · · · · · · · · · · · · ·	Model No.	Spec.
1	SYNERGY SO	CIENTECH CORP or Logitech	AHB572535PJT or 533-000120	3.7Vdc, 500mAh
2	SPRINGPOW	VER TECHNOLOGY SHENZHEN CO	652535 or 533-000121	3.7Vdc, 500mAh
3.	The EUT was	pre-tested under following test modes:		
Pre	-test Mode	Power		
Мо	de A	Power from battery 1		
Мо	de B	Power from battery 2		
Мо	de C	Power from USB interface		

From the above modes, the worst spurious emission was found in **Mode C**. Therefore only the test data of the modes were recorded in this report.

4. The above EUT information is declared by manufacturer and for more detailed features description, please refer to the manufacturer's specifications or user's manual.



3.2 Description of Test Modes

12 channels are provided to this EUT:

Channel	Frequency	Channel	Frequency
1	2405	7	2441
2	2408	8	2444
3	2414	9	2462
4	2417	10	2465
5	2432	11	2471
6	2435	12	2474



	APPLICABLE TO			DESCRIPTION	
ONFIGURE MODE	RE≥1G	RE<1G	PLC	APCM	DESCRIPTION
1	\checkmark	\checkmark	\checkmark	\checkmark	Power from USB interface (adapter)
2	-	-	\checkmark	-	Power from USB interface (Laptop)
ere Band	edge Measure Power Line C	Emission above 1G ement Conducted Emissior	F		Emission below 1GHz ort Conducted Measurement
Pre-Scar between architect	n has been available m ure). g channel(s	nodulations, dat) was (were) se	etermine th ta rates an elected for	d antenna por	mode from all possible combinations ts (if EUT with antenna diversity s listed below.
		TESTED CHANN	IFI MODI	JLATION TYPE	
AVAILABL 1 t	0 12	1, 8, 12 st (Below 1GH		GFSK	
AVAILABL 1 t Radiated En Pre-Scar between architecto	nission Tes has been available m ure).	1, 8, 12 st (Below 1GH conducted to de	z): etermine that rates and	GFSK le worst-case d antenna por	mode from all possible combinations ts (if EUT with antenna diversity s listed below.
AVAILABL 1 t adiated En Pre-Scar between architecto Following	nission Tes has been available m ure).	1, 8, 12 st (Below 1GH conducted to de nodulations, dat	z): etermine that rates and elected for	GFSK le worst-case d antenna por	ts (if EUT with antenna diversity
AVAILABL 1 t Radiated En Pre-Scar between architectr Following AVAILABL	n has been available m ure). g channel(s	1, 8, 12 st (Below 1GH conducted to de nodulations, dat) was (were) se	z): etermine that rates and elected for	GFSK le worst-case d antenna por the final test a	ts (if EUT with antenna diversity
AVAILABL 1 t 1 t Addiated En Pre-Scar between architectr Following AVAILABL 1 t Power Line Pre-Scar between architectr	n has been available m available m available m available m b 12 Conducted n has been available m available m available m	1, 8, 12 st (Below 1GH conducted to de nodulations, dat) was (were) se TESTED CHANN 8 d Emission Test conducted to de	z): etermine the ta rates and elected for IEL MODI St: etermine the ta rates and	GFSK de worst-case d antenna por the final test a JLATION TYPE GFSK de worst-case d antenna por	ts (if EUT with antenna diversity s listed below. mode from all possible combinations ts (if EUT with antenna diversity
AVAILABL 1 t 1 t 1 t 1 t 1 t 1 t 1 t 1 t 1 t 1 t	n has been available m available m available m available m b 12 Conducted n has been available m available m available m	1, 8, 12 st (Below 1GH conducted to de nodulations, dat) was (were) se TESTED CHANN 8 d Emission Tes conducted to de nodulations, dat	z): etermine that rates and elected for IEL MODI St: etermine that rates and elected for	GFSK de worst-case d antenna por the final test a JLATION TYPE GFSK de worst-case d antenna por	ts (if EUT with antenna diversity s listed below. mode from all possible combinations ts (if EUT with antenna diversity



Antenna Port Conducted Measurement:

- This item includes all test value of each mode, but only includes spectrum plot of worst value of each mode.
- Pre-Scan has been conducted to determine the worst-case mode from all possible combinations between available modulations, data rates and antenna ports (if EUT with antenna diversity architecture).
- Following channel(s) was (were) selected for the final test as listed below.

AVAILABLE CHANNEL	TESTED CHANNEL	MODULATION TYPE	
1 to 12	1, 8, 12	GFSK	

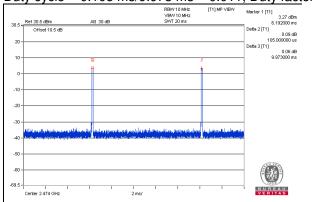
Test Condition:

APPLICABLE TO	ENVIRONMENTAL CONDITIONS	INPUT POWER (SYSTEM)	TESTED BY		
RE≥1G 23deg. C, 70%RH		120Vac, 60Hz	Jyunchun Lin		
RE<1G	23deg. C, 62%RH	120Vac, 60Hz	Jyunchun Lin		
PLC	PLC 21deg. C, 63%RH		21deg. C, 63%RH 120Vac, 60Hz		Jyunchun Lin
APCM	23deg. C, 65%RH	120Vac, 60Hz	Anderson Chen		



3.3 Duty Cycle of Test Signal

Duty cycle of test signal is < 98 %, duty factor shall be considered. Duty cycle = 0.105 ms/9.973 ms = 0.011, Duty factor = 10 * log(1/0.011) = 19.78





3.4 Description of Support Units

The EUT has been tested as an independent unit together with other necessary accessories or support units. The following support units or accessories were used to form a representative test configuration during the tests.

ID	Product	Brand	Model No.	Serial No.	FCC ID	Remarks
Α.	. USB Adapter ASUS		EXA1205UA	NA	NA	Provided by Lab
В.	Laptop	DELL	E5430	4YV4VY1	FCC DoC	Provided by Lab

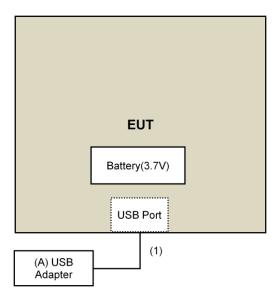
Note:

1. All power cords of the above support units are non-shielded (1.8m).

ID	ID Descriptions Qty.		Length (m) Shielding (Yes/No)		Cores (Qty.)	Remarks
1.	USB	1	0.7	Yes	0	Supplied by client

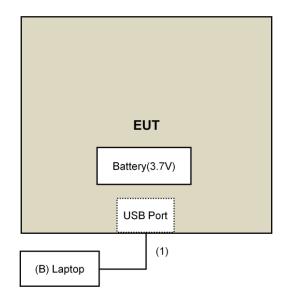
3.4.1 Configuration of System under Test

For Mode 1:





For Mode 2:





3.5 General Description of Applied Standards

The EUT is a RF Product. According to the specifications of the manufacturer, it must comply with the requirements of the following standards:

FCC Part 15, Subpart C (15.247) KDB 558074 D01 DTS Meas Guidance v03r05 ANSI C63.10-2013

All test items have been performed and recorded as per the above standards.



4 Test Types and Results

4.1 Radiated Emission and Bandedge Measurement

4.1.1 Limits of Radiated Emission and Bandedge Measurement

Radiated emissions which fall in the restricted bands must comply with the radiated emission limits specified as below table. Other emissions shall be at least 20dB below the highest level of the desired power:

Frequencies (MHz)	Field Strength (microvolts/meter)	Measurement Distance (meters)	
0.009 ~ 0.490	2400/F(kHz)	300	
0.490 ~ 1.705	24000/F(kHz)	30	
1.705 ~ 30.0	30	30	
30 ~ 88	100	3	
88 ~ 216	150	3	
216 ~ 960	200	3	
Above 960	500	3	

NOTE:

1. The lower limit shall apply at the transition frequencies.

- 2. Emission level $(dBuV/m) = 20 \log Emission level (uV/m)$.
- 3. For frequencies above 1000MHz, the field strength limits are based on average detector, however, the peak field strength of any emission shall not exceed the maximum permitted average limits, specified above by more than 20dB under any condition of modulation.



4.1.2 Test Instruments

DESCRIPTION &		SERIAL NO.	CALIBRATED	CALIBRATED
MANUFACTURER	MODEL NO.	SERIAL NU.	DATE	UNTIL
Test Receiver Keysight	N9038A	MY54450088	July 20, 2016	July 19, 2017
Pre-Amplifier ^(*) EMCI	EMC001340	980142	Jan. 20, 2016	Jan. 19, 2018
Loop Antenna ^(*) Electro-Metrics	EM-6879	264	Dec. 16, 2016	Dec. 15, 2018
RF Cable	NA	LOOPCAB-001 LOOPCAB-002	Jan. 18, 2016	Jan. 17, 2017
Pre-Amplifier Mini-Circuits	ZFL-1000VH2 B	AMP-ZFL-01	Nov. 10, 2016	Nov. 09, 2017
Trilog Broadband Antenna SCHWARZBECK	VULB 9168	9168-406	Jan. 04, 2016	Jan. 03, 2017
RF Cable	8D	966-4-1 966-4-2 966-4-3	Apr. 02, 2016	Apr. 01, 2017
Fixed attenuator Mini-Circuits	UNAT-5+	PAD-3m-4-01	Oct. 05, 2016	Oct. 04, 2017
Horn_Antenna SCHWARZBECK	BBHA 9120D	9120D-783	Jan. 19, 2016	Jan. 18, 2017
Pre-Amplifier Agilent	8449B	3008A01922	Sep. 18, 2016	Sep. 17, 2017
RF Cable	EMC104-SM- SM-2000 EMC104-SM- SM-5000 EMC104-SM- SM-5000	150318 150323 150324	Mar. 30, 2016	Mar. 29, 2017
Pre-Amplifier EMCI	EMC184045	980143	Jan. 15, 2016	Jan. 14, 2017
Horn_Antenna SCHWARZBECK	BBHA 9170	BBHA9170608	Jan. 08, 2016	Jan. 07, 2017
RF Cable	SUCOFLEX 102	36432/2 36441/2	Jan. 16, 2016	Jan. 15, 2017
Software	ADT_Radiated _V8.7.08	NA	NA	NA
Antenna Tower & Turn Table Max-Full	MF-7802	MF780208410	NA	NA
Boresight Antenna Fixture	FBA-01	FBA-SIP02	NA	NA

Note:

1. The calibration interval of the above test instruments is 12 months and the calibrations are traceable to NML/ROC and NIST/USA.

- 2. *The calibration interval of the above test instruments is 24 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 3. The test was performed in 966 Chamber No. 4.
- 4. The FCC Site Registration No. is 292998
- 5. The CANADA Site Registration No. is 20331-2
- 6. Tested Date: Dec. 22 to 27, 2016



4.1.3 Test Procedures

For Radiated emission below 30MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter chamber room. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. Both X and Y axes of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Quasi-Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.

NOTE:

1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 9kHz at frequency below 30MHz.

For Radiated emission above 30MHz

- a. The EUT was placed on the top of a rotating table 0.8 meters (for 30MHz ~ 1GHz) / 1.5 meters (for above 1GHz) above the ground at 3 meter chamber room for test. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The height of antenna is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rotatable table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to quasi-peak detect function and specified bandwidth with maximum hold mode when the test frequency is below 1 GHz.
- f. The test-receiver system was set to peak and average detect function and specified bandwidth with maximum hold mode when the test frequency is above 1 GHz. If the peak reading value also meets average limit, measurement with the average detector is unnecessary.

Note:

- 1. The resolution bandwidth and video bandwidth of test receiver/spectrum analyzer is 120kHz for Quasi-peak detection (QP) at frequency below 1GHz.
- 2. The resolution bandwidth of test receiver/spectrum analyzer is 1 MHz and the video bandwidth is 3 MHz for Peak detection (PK) at frequency above 1GHz.
- 3. The resolution bandwidth of test receiver/spectrum analyzer is 1MHz and the video bandwidth is ≥ 1/T (Duty cycle < 98%) or 10Hz (Duty cycle ≥ 98%) for Average detection (AV) at frequency above 1GHz.
- 4. All modes of operation were investigated and the worst-case emissions are reported.

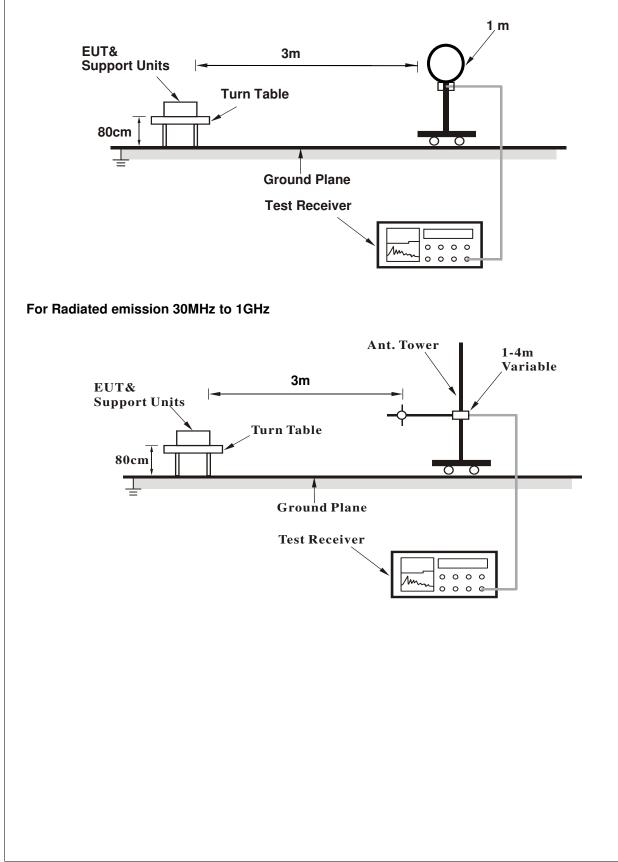
4.1.4 Deviation from Test Standard

No deviation.

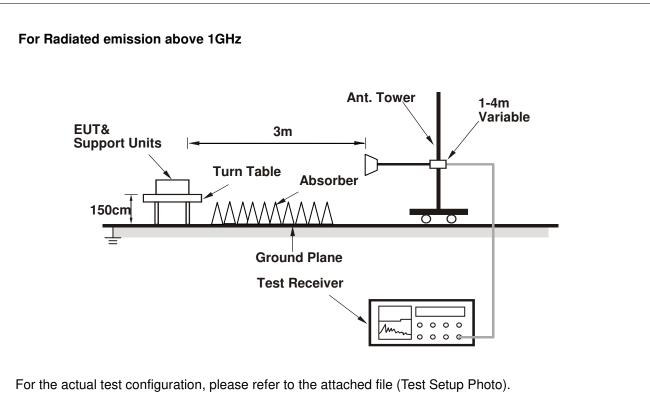


4.1.5 Test Setup

For Radiated emission below 30MHz







- 4.1.6 EUT Operating Conditions
- a. Contorlling software (RF Sample with Receiver model[nRF51822][Number Lock]) has been activated to set the EUT on specific status.



4.1.7 Test Results

Above 1GHz Data:

CHANNEL	TX Channel 1	DETECTOR	Peak (PK)
FREQUENCY RANGE	1GHz ~ 25GHz	FUNCTION	Average (AV)

		ANTENNA	POLARITY	& TEST DIS	TANCE: HO	RIZONTAL	AT 3 M	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	2390.00	61.3 PK	74.0	-12.7	1.22 H	38	65.0	-3.7
2	2390.00	38.1 AV	54.0	-15.9	1.22 H	38	41.8	-3.7
3	*2405.00	102.0 PK			1.22 H	38	105.7	-3.7
4	*2405.00	99.6 AV			1.22 H	38	103.3	-3.7
5	4810.00	44.0 PK	74.0	-30.0	1.55 H	69	41.8	2.2
6	4810.00	39.0 AV	54.0	-15.0	1.55 H	69	36.8	2.2
		ANTENNA	POLARITY	& TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	2390.00	56.2 PK	74.0	-17.8	3.38 V	353	59.9	-3.7
2	2390.00	37.8 AV	54.0	-16.2	3.38 V	353	41.5	-3.7
3	*2405.00	96.7 PK			3.38 V	353	100.4	-3.7
4	*2405.00	94.6 AV			3.38 V	353	98.3	-3.7
5	4810.00	43.1 PK	74.0	-30.9	2.88 V	32	40.9	2.2
6	4810.00	38.0 AV	54.0	-16.0	2.88 V	32	35.8	2.2

REMARKS:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) - Pre-Amplifier Factor(dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission Level - Limit value

5. " * ": Fundamental frequency.

CHANNEL	TX Channel 8	DETECTOR	Peak (PK)
FREQUENCY RANGE	1GHz ~ 25GHz	FUNCTION	Average (AV)

	ANTENNA POLARITY & TEST DISTANCE: HORIZONTAL AT 3 M								
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)	
1	*2444.00	102.1 PK			1.24 H	45	105.7	-3.6	
2	*2444.00	99.6 AV			1.24 H	45	103.2	-3.6	
3	4888.00	43.4 PK	74.0	-30.6	1.46 H	83	41.0	2.4	
4	4888.00	38.2 AV	54.0	-15.8	1.46 H	83	35.8	2.4	
5	7332.00	49.8 PK	74.0	-24.2	1.42 H	112	41.0	8.8	
6	7332.00	42.8 AV	54.0	-11.2	1.42 H	112	34.0	8.8	
		ANTENNA	POLARITY	& TEST DI	STANCE: V	ERTICAL A	Т 3 М		
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)	
1	*2444.00	97.1 PK			3.37 V	347	100.7	-3.6	
2	*2444.00	94.6 AV			3.37 V	347	98.2	-3.6	
3	4888.00	43.4 PK	74.0	-30.6	2.82 V	36	41.0	2.4	

REMARKS:

4888.00

7332.00

7332.00

4

5

6

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

-15.5

-24.3

-12.0

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) - Pre-Amplifier Factor(dB)

2.82 V

2.67 V

2.67 V

36

11

11

36.1

40.9

33.2

3. The other emission levels were very low against the limit.

54.0

74.0

54.0

4. Margin value = Emission Level - Limit value

5. " * ": Fundamental frequency.

38.5 AV

49.7 PK

42.0 AV

2.4

8.8

8.8

CHANNEL	TX Channel 12	DETECTOR	Peak (PK)
FREQUENCY RANGE	1GHz ~ 25GHz	FUNCTION	Average (AV)

		ANTENNA	POLARITY	& TEST DIS	TANCE: HO	RIZONTAL	AT 3 M	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2474.00	102.2 PK			1.23 H	27	105.7	-3.5
2	*2474.00	99.7 AV			1.23 H	27	103.2	-3.5
3	2483.50	66.9 PK	74.0	-7.1	1.23 H	27	70.5	-3.6
4	2483.50	38.5 AV	54.0	-15.5	1.23 H	27	42.1	-3.6
5	4948.00	43.3 PK	74.0	-30.7	1.50 H	84	40.7	2.6
6	4948.00	38.3 AV	54.0	-15.7	1.50 H	84	35.7	2.6
7	7422.00	49.5 PK	74.0	-24.5	1.45 H	120	40.3	9.2
8	7422.00	43.0 AV	54.0	-11.0	1.45 H	120	33.8	9.2
		ANTENNA	POLARITY	& TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	*2474.00	96.9 PK			3.38 V	359	100.4	-3.5
2	*2474.00	94.4 AV			3.38 V	359	97.9	-3.5
3	2483.50	61.9 PK	74.0	-12.1	3.38 V	359	65.5	-3.6
4	2483.50	38.3 AV	54.0	-15.7	3.38 V	359	41.9	-3.6
5	4948.00	43.1 PK	74.0	-30.9	2.87 V	32	40.5	2.6
6	4948.00	38.1 AV	54.0	-15.9	2.87 V	32	35.5	2.6
7	7422.00	49.2 PK	74.0	-24.8	2.66 V	12	40.0	9.2
8	7422.00	42.4 AV	54.0	-11.6	2.66 V	12	33.2	9.2

REMARKS:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)
 The other emission levels were very low against the limit.

4. Margin value = Emission Level – Limit value

5. " * ": Fundamental frequency.

Report No.: RF161220E09-1



Below 1GHz Data:

CHANNEL	TX Channel 8	DETECTOR	
FREQUENCY RANGE	9kHz ~ 1GHz	FUNCTION	Quasi-Peak (QP)

		ANTENNA	POLARITY	& TEST DIS	TANCE: HO	RIZONTAL	AT 3 M	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	105.64	24.3 QP	43.5	-19.2	2.00 H	76	36.0	-11.7
2	150.91	20.8 QP	43.5	-22.7	2.50 H	360	28.8	-8.0
3	482.50	23.0 QP	46.0	-23.0	2.00 H	292	25.9	-2.9
4	627.35	26.1 QP	46.0	-19.9	2.50 H	360	25.8	0.3
5	780.29	27.8 QP	46.0	-18.2	1.00 H	80	25.2	2.6
6	942.12	29.8 QP	46.0	-16.2	1.50 H	329	25.1	4.7
		ANTENNA	POLARITY	& TEST DI	STANCE: V	ERTICAL A	Т 3 М	
NO.	FREQ. (MHz)	EMISSION LEVEL (dBuV/m)	LIMIT (dBuV/m)	MARGIN (dB)	ANTENNA HEIGHT (m)	TABLE ANGLE (Degree)	RAW VALUE (dBuV)	CORRECTION FACTOR (dB/m)
1	104.33	26.6 QP	43.5	-16.9	2.00 V	360	38.5	-11.9
2	144.02	21.5 QP	43.5	-22.0	1.00 V	66	29.6	-8.1
3	458.30	22.5 QP	46.0	-23.5	2.50 V	210	25.8	-3.3
4	600.92	25.1 QP	46.0	-20.9	2.50 V	207	25.2	-0.1
5	779.11	27.9 QP	46.0	-18.1	2.00 V	344	25.3	2.6
6	940.18	29.6 QP	46.0	-16.4	1.50 V	60	24.8	4.8

REMARKS:

1. Emission Level(dBuV/m) = Raw Value(dBuV) + Correction Factor(dB/m)

2. Correction Factor(dB/m) = Antenna Factor(dB/m) + Cable Factor(dB) – Pre-Amplifier Factor(dB)

3. The other emission levels were very low against the limit.

4. Margin value = Emission Level – Limit value



4.2 Conducted Emission Measurement

4.2.1 Limits of Conducted Emission Measurement

	Conducted I	Limit (dBuV)		
Frequency (MHz)	Quasi-peak	Average		
0.15 - 0.5	66 - 56	56 - 46		
0.50 - 5.0	56	46		
5.0 - 30.0	60	50		

Note: 1. The lower limit shall apply at the transition frequencies.

2. The limit decreases in line with the logarithm of the frequency in the range of 0.15 to 0.50MHz.

4.2.2 Test Instruments

DESCRIPTION & MANUFACTURER	MODEL NO.	SERIAL NO.	CALIBRATED DATE	CALIBRATED UNTIL
Test Receiver R&S	ESCS 30	847124/029	Oct. 24, 2016	Oct. 23, 2017
Line-Impedance Stabilization Network (for EUT) R&S	ESH3-Z5	848773/004	Oct. 26, 2016	Oct. 25, 2017
RF Cable	5D-FB	COCCAB-001	Sep. 30, 2016	Sep. 29, 2017
10 dB PAD Mini-Circuits	HAT-10+	CONATT-004	June 20, 2016	June 19, 2017
Software BVADT	BVADT_Cond_ V7.3.7.4	NA	NA	NA

Note:

- 1. The calibration interval of the above test instruments are 12 months and the calibrations are traceable to NML/ROC and NIST/USA.
- 2. The test was performed in Shielded Room No. 1.
- 3. Tested Date: Dec. 27, 2016

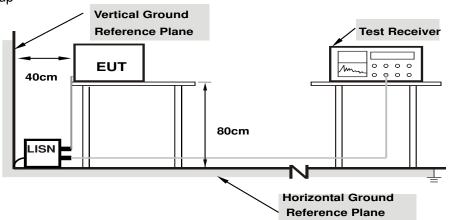


4.2.3 Test Procedures

- a. The EUT was placed 0.4 meters from the conducting wall of the shielded room with EUT being connected to the power mains through a line impedance stabilization network (LISN). Other support units were connected to the power mains through another LISN. The two LISNs provide 50 ohm/ 50uH of coupling impedance for the measuring instrument.
- b. Both lines of the power mains connected to the EUT were checked for maximum conducted interference.
- c. The frequency range from 150kHz to 30MHz was searched. Emission levels under (Limit 20dB) was not recorded.
- **NOTE:** The resolution bandwidth and video bandwidth of test receiver is 9kHz for quasi-peak detection (QP) and average detection (AV) at frequency 0.15MHz-30MHz.
- 4.2.4 Deviation from Test Standard

No deviation.

4.2.5 Test Setup



Note: 1.Support units were connected to second LISN.

For the actual test configuration, please refer to the attached file (Test Setup Photo).

4.2.6 EUT Operating Conditions

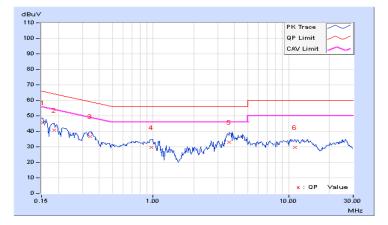
Same as 4.1.6.

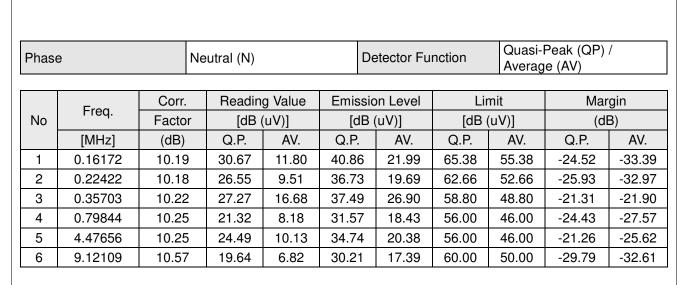


4.2.7 Test Results (Mode 1)

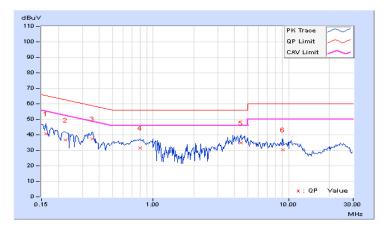
Phase Line (L)					D	Detector Function Quasi-Peak (QP) / Average (AV)				
	Frag	Corr.	Readin	g Value	Emissi	on Level	Limit		Margin	
No	Freq.	Factor	[dB	(uV)]	[dB (uV)]		[dB ([uV)]	(dl	3)
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.15391	10.20	35.38	21.99	45.58	32.19	65.79	55.79	-20.21	-23.60
2	0.18516	10.20	30.68	15.90	40.88	26.10	64.25	54.25	-23.37	-28.15
3	0.34141	10.23	26.40	12.99	36.63	23.22	59.17	49.17	-22.54	-25.95
4	0.96641	10.30	19.34	5.90	29.64	16.20	56.00	46.00	-26.36	-29.80
5	3.66016	10.31	22.56	8.53	32.87	18.84	56.00	46.00	-23.13	-27.16
6	11.20313	10.87	18.83	9.88	29.70	20.75	60.00	50.00	-30.30	-29.25

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.





- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
 - 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.

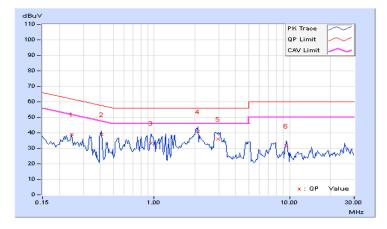




4.2.8 Test Results (Mode 2)

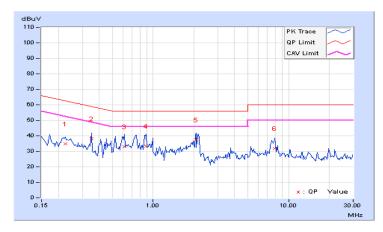
Phase Line (L)				C	Detector Function Quasi-Peak (QP) / Average (AV)					
	Frag	Corr.	Readin	g Value	Emiss	ion Level	Limit		Margin	
No	Freq.	Factor	[dB	(uV)]	[dB (uV)]		[dB ((uV)]	(dB)	
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.24766	10.20	28.72	22.36	38.92	32.56	61.84	51.84	-22.92	-19.28
2	0.41172	10.22	28.73	25.83	38.95	36.05	57.61	47.61	-18.66	-11.56
3	0.94297	10.26	23.08	15.83	33.34	26.09	56.00	46.00	-22.66	-19.91
4	2.10156	10.24	30.65	23.64	40.89	33.88	56.00	46.00	-15.11	-12.12
5	2.96484	10.24	25.75	14.36	35.99	24.60	56.00	46.00	-20.01	-21.40
6	9.47656	10.52	20.95	14.65	31.47	25.17	60.00	50.00	-28.53	-24.83

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.



Phase Neutral (N)				D	etector Fu	nction	Quasi- Averag	Peak (QP) le (AV)	/	
	From	Corr.	Readin	g Value	Emissi	ion Level	Lir	nit	Mar	gin
No	Freq.	Facto	ctor [dB (uV)]		[dB	[dB (uV)] [dB (u		uV)] (c		B)
	[MHz]	(dB)	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.	Q.P.	AV.
1	0.22422	10.17	24.52	20.18	34.69	30.35	62.66	52.66	-27.97	-22.31
2	0.34922	10.20	27.86	20.40	38.06	30.60	58.98	48.98	-20.92	-18.38
3	0.61094	10.22	22.74	18.00	32.96	28.22	56.00	46.00	-23.04	-17.78
4	0.88828	10.23	22.98	9.15	33.21	19.38	56.00	46.00	-22.79	-26.62
5	2.07031	10.28	27.00	18.15	37.28	28.43	56.00	46.00	-18.72	-17.57
6	7.87500	10.37	21.39	13.04	31.76	23.41	60.00	50.00	-28.24	-26.59

- 1. Q.P. and AV. are abbreviations of quasi-peak and average individually.
- 2. The emission levels of other frequencies were very low against the limit.
- 3. Margin value = Emission level Limit value
- 4. Correction factor = Insertion loss + Cable loss
- 5. Emission Level = Correction Factor + Reading Value.



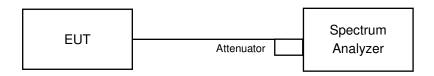


4.3 6dB Bandwidth Measurement

4.3.1 Limits of 6dB Bandwidth Measurement

The minimum of 6dB Bandwidth Measurement is 0.5 MHz.

4.3.2 Test Setup



4.3.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.3.4 Test Procedure

- a. Set resolution bandwidth (RBW) = 100kHz
- b. Set the video bandwidth (VBW) \geq 3 x RBW, Detector = Peak.
- c. Trace mode = max hold.
- d. Sweep = auto couple.
- e. Measure the maximum width of the emission that is constrained by the frequencies associated with the two amplitude points (upper and lower) that are attenuated by 6 dB relative to the maximum level measured in the fundamental emission
- 4.3.5 Deviation fromTest Standard

No deviation.

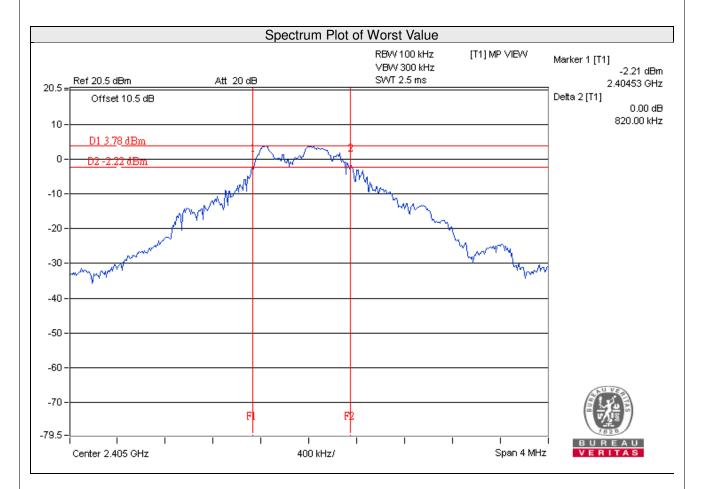
4.3.6 EUT Operating Conditions

The software provided by client to enable the EUT under transmission condition continuously at lowest, middle and highest channel frequencies individually.



4.3.7 Test Result

Channel	Frequency (MHz)	6dB Bandwidth (MHz)	Minimum Limit (MHz)	Pass / Fail
1	2405	0.82	0.5	PASS
8	2444	0.88	0.5	PASS
12	2474	0.87	0.5	PASS



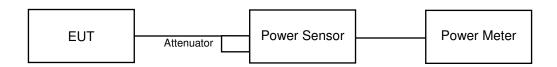


4.4 Conducted Output Power Measurement

4.4.1 Limits of Conducted Output Power Measurement

For systems using digital modulation in the 2400–2483.5 MHz bands: 1 Watt (30dBm)

4.4.2 Test Setup



4.4.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.4.4 Test Procedures

A peak / average power sensor was used on the output port of the EUT. A power meter was used to read the response of the peak / average power sensor. Record the power level.

4.4.5 Deviation from Test Standard

No deviation.

4.4.6 EUT Operating Conditions

Same as Item 4.3.6.



4.4.7 Test Results

FOR PEAK POWER

Channel	Frequency (MHz)	Peak Power (mW)	Peak Power (dBm)	Limit (dBm)	Pass/Fail
1	2405	2.438	3.87	30	Pass
8	2444	2.5	3.98	30	Pass
12	2474	2.41	3.82	30	Pass

FOR AVERAGE POWER

Channel	Frequency (MHz)	Average Power (mW)	Average Power (dBm)
1	2405	2.427	3.85
8	2444	2.489	3.96
12	2474	2.393	3.79

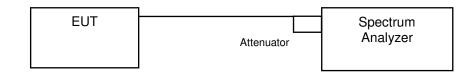


4.5 Power Spectral Density Measurement

4.5.1 Limits of Power Spectral Density Measurement

The Maximum of Power Spectral Density Measurement is 8dBm.

4.5.2 Test Setup



4.5.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.5.4 Test Procedure

- a. Set analyzer center frequency to DTS channel center frequency.
- b. Set the span to 1.5 times the DTS bandwidth.
- c. Set the RBW to: $3 \text{ kHz} \le \text{RBW} \le 100 \text{ kHz}$.
- d. Set the VBW \geq 3 × RBW.
- e. Detector = peak.
- f. Sweep time = auto couple.
- g. Trace mode = max hold.
- h. Allow trace to fully stabilize.
- i. Use the peak marker function to determine the maximum amplitude level within the RBW.

4.5.5 Deviation from Test Standard

No deviation.

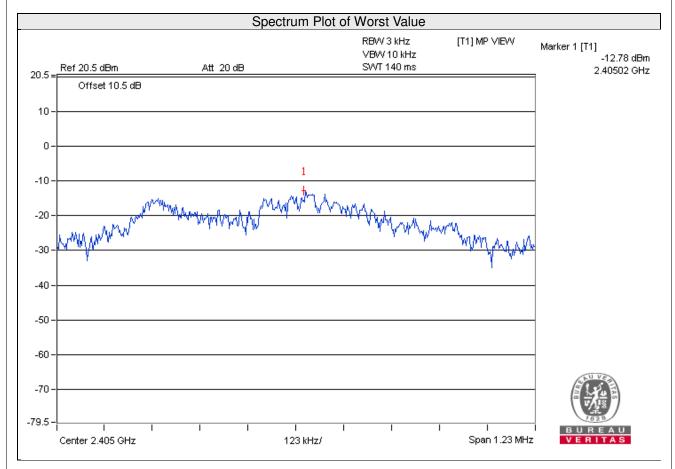
4.5.6 EUT Operating Condition

Same as Item 4.3.6



4.5.7 Test Results

Channel	Freq. (MHz)	PSD (dBm/3kHz)	Limit (dBm/3kHz)	Pass /Fail
1	2405	-12.78	8	Pass
8	2444	-13.60	8	Pass
12	2474	-13.21	8	Pass





4.6 Conducted Out of Band Emission Measurement

4.6.1 Limits of Conducted Out of Band Emission Measurement

Below 20dB of the highest emission level of operating band (in 100kHz Resolution Bandwidth).

4.6.2 Test Setup



4.6.3 Test Instruments

Refer to section 4.1.2 to get information of above instrument.

4.6.4 Test Procedure

MEASUREMENT PROCEDURE REF

- 1. Set the RBW = 100 kHz.
- 2. Set the VBW \geq 300 kHz.
- 3. Detector = peak.
- 4. Sweep time = auto couple.
- 5. Trace mode = max hold.
- 6. Allow trace to fully stabilize.
- 7. Use the peak marker function to determine the maximum power level in any 100 kHz band segment within the fundamental EBW.

MEASUREMENT PROCEDURE OOBE

- 1. Set RBW = 100 kHz.
- 2. Set VBW ≥ 300 kHz.
- 3. Detector = peak.
- 4. Sweep = auto couple.
- 5. Trace Mode = max hold.
- 6. Allow trace to fully stabilize.
- 7. Use the peak marker function to determine the maximum amplitude level.

4.6.5 Deviation from Test Standard

No deviation.

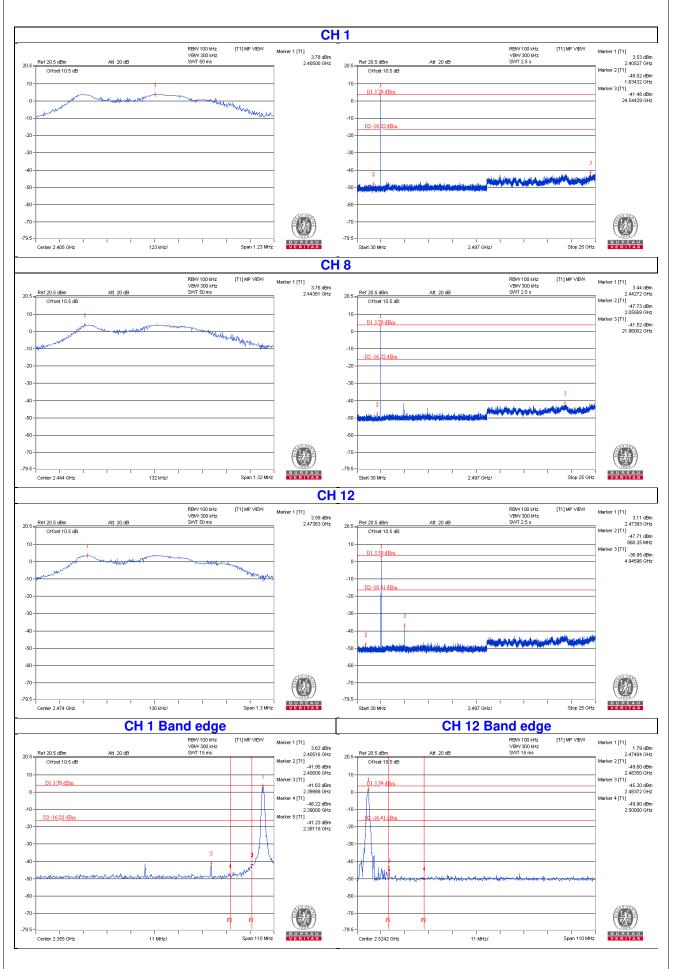
4.6.6 EUT Operating Condition

Same as Item 4.3.6

4.6.7 Test Results

The spectrum plots are attached on the following pages. D1 line indicates the highest level, and D2 line indicates the 20dB offset below D1. It shows compliance with the requirement.







5 Pictures of Test Arrangements

Please refer to the attached file (Test Setup Photo).



Appendix – Information on the Testing Laboratories

We, Bureau Veritas Consumer Products Services (H.K.) Ltd., Taoyuan Branch, were founded in 1988 to provide our best service in EMC, Radio, Telecom and Safety consultation. Our laboratories are accredited and approved according to ISO/IEC 17025.

If you have any comments, please feel free to contact us at the following:

Linko EMC/RF Lab Tel: 886-2-26052180 Fax: 886-2-26051924 Hsin Chu EMC/RF/Telecom Lab Tel: 886-3-6668565 Fax: 886-3-6668323

Hwa Ya EMC/RF/Safety Lab Tel: 886-3-3183232 Fax: 886-3-3270892

Email: <u>service.adt@tw.bureauveritas.com</u> Web Site: <u>www.bureauveritas-adt.com</u>

The address and road map of all our labs can be found in our web site also.

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